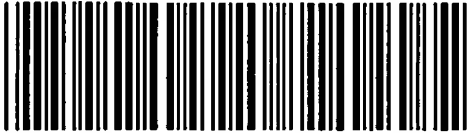


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/683,765	STRAYER, MARK	
	Examiner	Art Unit	
	Hae M. Hyeon	2839	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
439	652	2/05	hnh
439	131	↓	↓

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Update Search Done	2/05	hnh